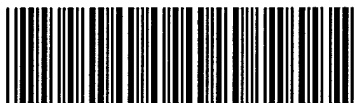


Search Notes

Application/Control No.

10/626,574

Examiner

David Buttner

Applicant(s)/Patent under
Reexamination

MISHIMA ET AL.

Art Unit

1712

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
523	all	2/3/2006	DB
524	all	2/3/2006	DB
428	all	2/3/2006	DB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/3/2006	DB